

Search Notes

Application/Control No.

10/024,145

Examiner

Andrew Hwa S. Lee

Applicant(s)/Patent under
Reexamination

NAKAYAMA, SHIGERU

Art Unit

2877

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/8/05	ah